

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/718,151	LIN, I-JONG		
Examiner	Art Unit		
Alex Liew	2624		

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
	- 3/25/2007	AL		
382/173 limited to text search	3/25/2007	AL		
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